

IGBT

SGW20N60RUF

Short Circuit Rated IGBT

General Description

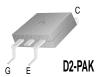
Fairchild's RUF series of Insulated Gate Bipolar Transistors (IGBTs) provide low conduction and switching losses as well as short circuit ruggedness. The RUF series is designed for applications such as motor control, uninterrupted power supplies (UPS) and general inverters where short circuit ruggedness is a required feature.

Features

- Short circuit rated 10 μ s @ $T_C = 100$ °C, $V_{GE} = 15V$
- High speed switching
- Low saturation voltage : $V_{CE(sat)} = 2.2 \text{ V } @ I_C = 20 \text{A}$
- High input impedance

Applications

AC & DC motor controls, general purpose inverters, robotics, and servo controls.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		SGW20N60RUF	Units
V _{CES}	Collector-Emitter Voltage		600	V
V _{GES}	Gate-Emitter Voltage		± 20	V
	Collector Current	@ T _C = 25°C	32	Α
IC	Collector Current	@ T _C = 100°C	20	А
I _{CM (1)}	Pulsed Collector Current		60	Α
	Short Circuit Withstand Time	@ T _C = 100°C	10	μs
T _{SC}	Maximum Power Dissipation	@ T _C = 25°C	195	W
	Maximum Power Dissipation	@ T _C = 100°C	75	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes

(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.64	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (PCB Mount) (2)		40	°C/W

Notes:

(2) Mounted on 1" squre PCB (FR4 or G-10 Material)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600			V
$\Delta B_{VCES}/$ ΔT_J	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0V, I _C = 1mA		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Char	racteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 20$ mA, $V_{CE} = V_{GE}$	5.0	6.0	8.5	V
VGE(tn)	Collector to Emitter	$I_C = 20A$, $V_{GE} = 15V$		2.2	2.8	V
$V_{CE(sat)}$	Saturation Voltage	$I_C = 32A$, $V_{GE} = 15V$		2.5		V
D	, ,	10 02.15, 1GE 101				-
•	C Characteristics Input Capacitance			1323		pF
C _{ies}	Output Capacitance	$V_{CE} = 30V_{V_{GE}} = 0V_{V_{GE}}$		254		pF
C _{oes} C _{res}	Reverse Transfer Capacitance	f = 1MHz		47		pF
	ng Characteristics Turn-On Delay Time			30		ns
t _{d(on)}	Turn-On Delay Time			30		ns
t _r	Rise Time			49		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$		48	70	ns
t _f	Fall Time	$R_G = 10\Omega, V_{GE} = 15V,$		152	200	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C		524		uJ
E _{off}	Turn-Off Switching Loss			473		uJ
E _{ts}	Total Switching Loss			997	1400	uJ
t _{d(on)}	Turn-On Delay Time			30		ns
t _r	Rise Time			51		ns
t _{d(off)}	Turn-Off Delay Time	$V_{CC} = 300 \text{ V}, I_{C} = 20\text{A},$		52	75	ns
t _f	Fall Time	$R_G = 10\Omega, V_{GE} = 15V,$		311	400	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 125°C		568		uJ
E _{off}	Turn-Off Switching Loss	1		1031		uJ
E _{ts}	Total Switching Loss			1599	2240	uJ
T _{sc}	Short Circuit Withstand Time	V _{CC} = 300 V, V _{GE} = 15V @ T _C = 100°C	10			us
Q _q	Total Gate Charge			55	80	nC
Q _{qe}	Gate-Emitter Charge	$V_{CE} = 300 \text{ V}, I_{C} = 20\text{A},$		10	15	nC
Q _{gc}	Gate-Collector Charge	V _{GE} = 15V		25	40	nC
90	Internal Emitter Inductance	Measured 5mm from PKG		7.5		nH

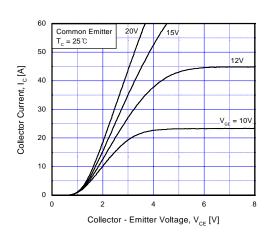


Fig 1. Typical Output Characteristics

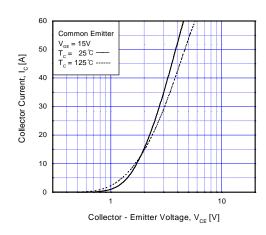


Fig 2. Typical Saturation Voltage Characteristics

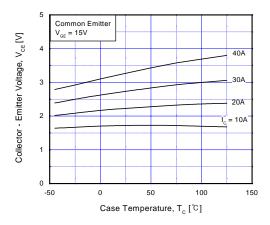


Fig 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

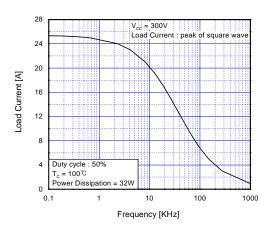


Fig 4. Load Current vs. Frequency

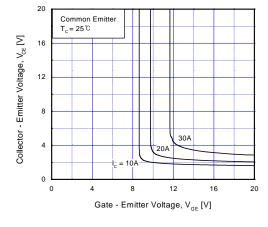


Fig 5. Saturation Voltage vs. V_{GE}

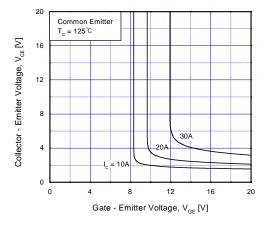
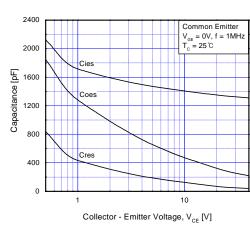


Fig 6. Saturation Voltage vs. V_{GE}

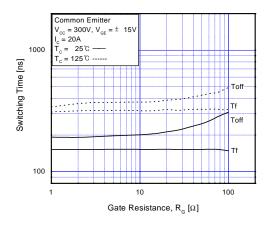
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Common Emitter $V_{cc} = 300V, V_{ce} = \pm 15V$ $I_c = 20A$ $T_c = 25^{\circ}C$ $T_c = 125^{\circ}C$ $T_r = 100$ $T_r = 100$

Fig 7. Capacitance Characteristics

Fig 8. Turn-On Characteristics vs.
Gate Resistance



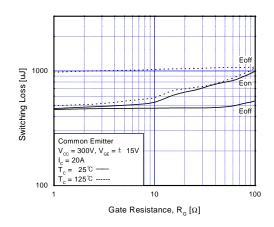
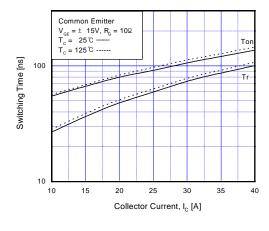


Fig 9. Turn-Off Characteristics vs.
Gate Resistance

Fig 10. Switching Loss vs. Gate Resistance



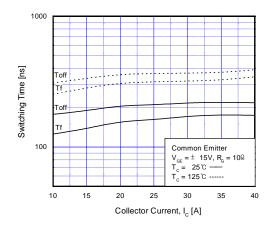
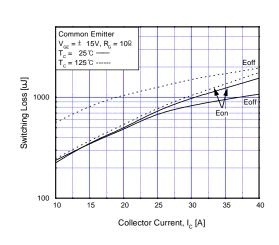


Fig 11. Turn-On Characteristics vs. Collector Current

Fig 12. Turn-Off Characteristics vs. Collector Current



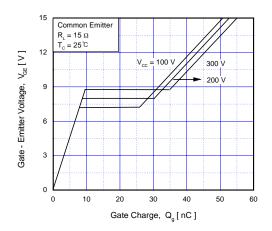
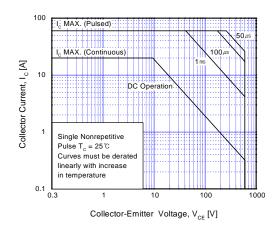


Fig 13. Switching Loss vs. Collector Current

Fig 14. Gate Charge Characteristics



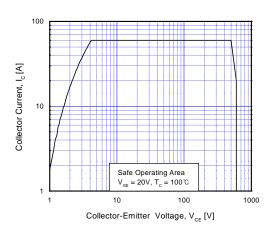


Fig 15. SOA Characteristics

Fig 16. Turn-Off SOA Characteristics

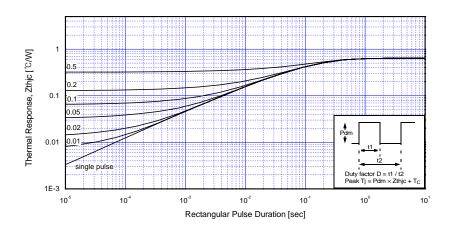
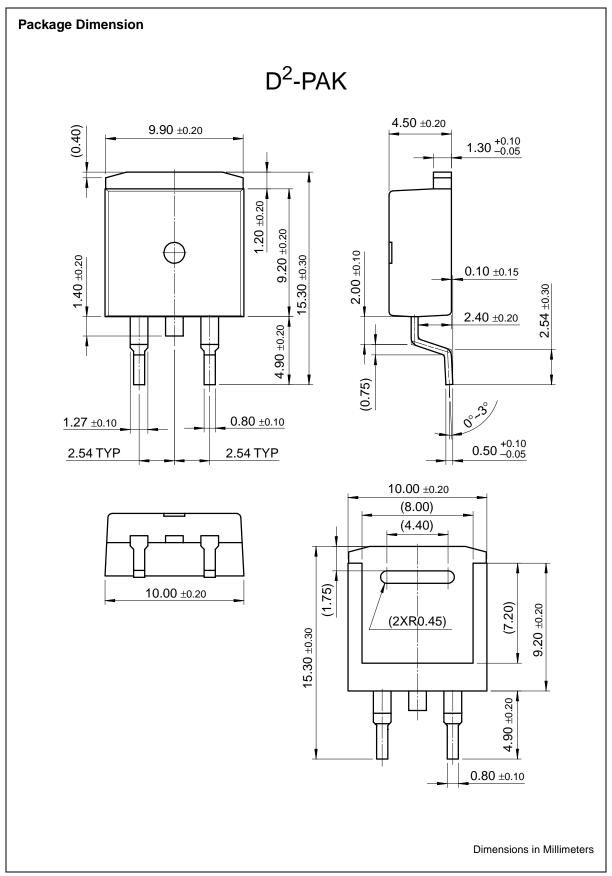


Fig 17. Transient Thermal Impedance of IGBT



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